# **Dual J-K Master-Slave Flip-Flop**

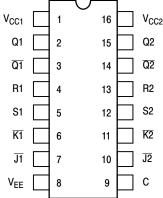
The MC10135 is a dual master–slave dc coupled J–K flip–flop. Asynchro– nous set (S) and reset (R) are provided. The set and reset inputs override the clock.

A common clock is provided with separate  $\overline{J}$ - $\overline{K}$  inputs. When the clock is static, the  $\overline{J}$ - $\overline{K}$  inputs do not effect the output.

The output states of the flip-flop change on the positive transition of the clock.

- $P_D = 280 \text{ mW typ/pkg (No Load)}$
- $f_{Tog} = 140 \text{ MHz typ}$
- $t_{pd} = 3.0 \text{ ns typ}$
- $t_r$ ,  $t_f = 2.5$  ns typ (20%–80%)

# DIP PIN ASSIGNMENT



Pin assignment is for Dual-in-Line Pack For PLCC pin assignment, see the Pin Con Tables on page 18 of the ON Semiconductor Data Book (DL122/D).

# S1 5 LOGIC DIAGRAM S1 7 Q1 2 K1 6 Q1 3 R1 4 C 9 S2 12 J2 10 C 15 K2 2 Fin 16

### **CLOCK J-K TRUTH TABLE\***

= PIN 8

R	S	Q <sub>n+1</sub>
LLII	LILI	Q <sub>c</sub> H L V.D.

**R-S TRUTH TABLE** 

N.D. = Not Defined

J	K	Q <sub>n+1</sub>
L	L	$\overline{Q_n}$
Н	L	L
L	Н	Н
Н	Н	$Q_n$

\*Output states change on positive transition of clock for  $\overline{J}$ – $\overline{K}$  input condition present.



### ON Semiconductor

http://onsemi.com

### MARKING DIAGRAMS



CDIP-16 L SUFFIX CASE 620





PDIP-16 P SUFFIX CASE 648





PLCC-20 FN SUFFIX CASE 775



A = Assembly Location

WL = Wafer Lot YY = Year

WW = Work Week

### **ORDERING INFORMATION**

Device	Package	Shipping
MC10135L	CDIP-16	25 Units / Rail
MC10135P	PDIP-16	25 Units / Rail
MC10135FN	PLCC-20	46 Units / Rail

### MC10135

### ELECTRICAL CHARACTERISTICS

			Test Limits							
		Pin Under	-30	)°C		+25°C		+85	i°C	
Characteristic	Symbol	Test	Min	Max	Min	Тур	Max	Min	Max	Unit
Power Supply Drain Current	Ι <sub>Ε</sub>	8		75		54	68		75	mAdc
Input Current	I <sub>inH</sub>	6,7,9,10,11 4,5,12,13		425 620			265 390		265 390	μAdc
	I <sub>inL</sub>	4,5,6,7,9, 10,11,12,13	0.5 0.5		0.5 0.5			0.3 0.3		μAdc
Output Voltage Logic 1	V <sub>OH</sub>	2 2 ( <b>3.</b> )	-1.060 -1.060	-0.890 -0.890	-0.960 -0.960		-0.810 -0.810	-0.890 -0.890	-0.700 -0.700	Vdc
Output Voltage Logic 0	V <sub>OL</sub>	3 3 ( <b>3.</b> )	-1.890 -1.890	-1.675 -1.675	-1.850 -1.850		-1.650 -1.650	-1.825 -1.825	-1.615 -1.615	Vdc
Threshold Voltage Logic 1	V <sub>OHA</sub>	2 2 ( <b>4.</b> )	-1.080 -1.080		-0.980 -0.980			-0.910 -0.910		Vdc
Threshold Voltage Logic 0	$V_{OLA}$	3 3 ( <b>4.</b> )		-1.655 -1.655			-1.630 -1.630		-1.595 -1.595	Vdc
Switching Times (50 $\Omega$ Load) Clock Input										ns
Propagation Delay	t <sub>9+2+</sub> t <sub>9+2-</sub>	2 2	1.8 1.8	5.0 5.0	1.8 1.8	3.0 3.0	4.5 4.5	1.8 1.8	4.6 4.6	
Rise Time (20 to 80%)	t <sub>2+</sub> , t <sub>3+</sub>	2, 3	1.1	4.8	1.1	2.0	4.5	1.1	4.7	
Fall Time (20 to 80%)	t <sub>2-</sub> , t <sub>3-</sub>	2, 3	1.1	4.8	1.1	2.0	4.5	1.1	4.7	
Set Input										ns
Propagation Delay	t <sub>5+2+</sub> t <sub>12+15+</sub> t <sub>5+3-</sub> t <sub>12+14-</sub>	2 15 3 14	1.8 1.8 1.8 1.8	5.6 5.6 5.6 5.6	1.8 1.8 1.8 1.8	3.0 3.0 3.0 3.0	5.0 5.0 5.0 5.0	1.8	5.2 5.2 5.2 5.2	
Reset Input										ns
Propagation Delay	t <sub>4+2</sub> - t <sub>4+3</sub> - t <sub>13+15</sub> - t <sub>13+14+</sub>	2 3 15 14	1.8 1.8 1.8 1.8	5.6 5.6 5.6 5.6	1.8 1.8 1.8 1.8	3.0 3.0 3.0 3.0	5.0 5.0 5.0 5.0	1.8 1.8 1.8 1.8	5.2 5.2 5.2 5.2	
Setup Time	t <sub>setup</sub>	7	2.5		2.5	1.0		2.5		ns
Hold Time	t <sub>hold</sub>	7	1.5		1.5	1.0		2.5		ns
Toggle Frequency (Max)	f <sub>tog</sub>	2	125		125	140		125		MHz

 $V_{IHmax}$ 3. Output level to be measured after a clock pulse has been applied to the  $\overline{C}_{\text{E}}$  Input (Pin 6)  $V_{IHAmax}$ 4. Output level to be measured after a clock pulse has been applied to the  $\overline{\text{C}}_{\text{E}}$  Input (Pin 6)

Individually test each input; apply V<sub>IHmax</sub> to pin under test.
 Individually test each input; apply V<sub>ILmin</sub> to pin under test.

### MC10135

### ENTRICAD CHARACTERISTICS (continued)

			TEST VOLTAGE VALUES (Volts)					
	@ Test	Temperature	V <sub>IHmax</sub>	$V_{ILmin}$	V <sub>IHAmin</sub>	V <sub>ILAmax</sub>	V <sub>EE</sub>	
		–30°C	-0.890	-1.890	-1.205	-1.500	-5.2	
		+25°C	-0.810	-1.850	-1.105	-1.475	-5.2	
		+85°C	-0.700	-1.825	-1.035	-1.440	-5.2	
		Pin Under	TEST V	OLTAGE A	PPLIED TO I	PINS LISTED E	BELOW	ον \
Characteristic	Symbol	Test	V <sub>IHmax</sub>	V <sub>ILmin</sub>	V <sub>IHAmin</sub>	V <sub>ILAmax</sub>	V <sub>EE</sub>	(V <sub>CC</sub> ) Gnd
Power Supply Drain Current	ΙE	8					8	1, 16
Input Current	I <sub>inH</sub>	6,7,9,10,11 4,5,12,13	Note 1. Note 1.				8 8	1, 16 1, 16
	I <sub>inL</sub>	4,5,6,7,9, 10,11,12,13		Note 2. Note 2.			8 8	1, 16 1, 16
Output Voltage Logic 1	V <sub>OH</sub>	2 2 ( <b>3.</b> )	5 6				8 8	1, 16 1, 16
Output Voltage Logic 0	V <sub>OL</sub>	3 3 ( <b>3.</b> )	5 6				8 8	1, 16 1, 16
Threshold Voltage Logic 1	V <sub>OHA</sub>	2 2 ( <b>4.</b> )	6		5		8 8	1, 16 1, 16
Threshold Voltage Logic 0	V <sub>OLA</sub>	3 3 ( <b>4.</b> )	6		5		8 8	1, 16 1, 16
Switching Times (50 $\Omega$ Load) Clock Input					Pulse In	Pulse Out	–3.2 V	+2.0 V
Propagation Delay	t <sub>9+2+</sub> t <sub>9+2-</sub>	2 2			9 9	2 2	8 8	1, 16 1, 16
Rise Time (20 to 80%)	t <sub>2+</sub> , t <sub>3+</sub>	2, 3			9	2, 3	8	1, 16
Fall Time (20 to 80%)	t <sub>2-</sub> , t <sub>3-</sub>	2, 3			9	2, 3	8	1, 16
Set Input Propagation Delay	t <sub>5+2+</sub> t <sub>12+15+</sub> t <sub>5+3-</sub> t <sub>12+14-</sub>	2 15 3 14			5 12 5 12	2 15 3 14	8 8 8 8	1, 16 1, 16 1, 16 1, 16
Reset Input Propagation Delay	t <sub>4+2</sub> - t <sub>4+3</sub> - t <sub>13+15</sub> - t <sub>13+14+</sub>	2 3 15 14			4 4 13 13	2 3 15 14	8 8 8 8	1, 16 1, 16 1, 16 1, 16
Setup Time	t <sub>setup</sub>	7			6, 9	2	8	1, 16
Hold Time	t <sub>hold</sub>	7			6, 9	2	8	1, 16
Toggle Frequency (Max)	f <sub>tog</sub>	2			9	2	8	1, 16

1.	Individually test each input; apply V <sub>IHmax</sub> to pin under test.
2.	Individually test each input; apply V <sub>II min</sub> to pin under test.

,	16111111	

3.	Output level to be measured after a clock pulse has been applied to the $\overline{C}_{E}$ Input (Pin 6)		V <sub>IHmax</sub> V <sub>ILmin</sub>
4.	Output level to be measured after a clock pulse has been applied to the $\overline{C}_{E}$ Input (Pin 6)		V <sub>IHAma</sub>

Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to -2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

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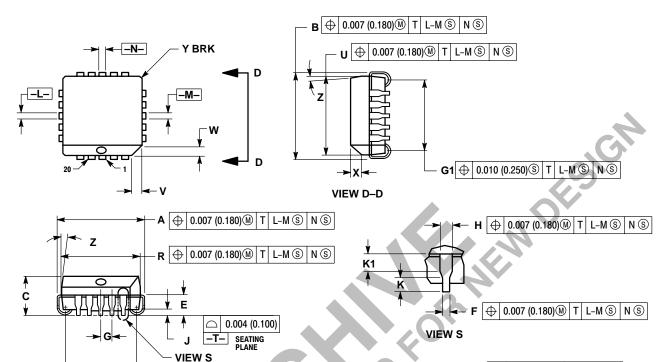
G1 ⊕ 0.010 (0.250)③ T L-M ⑤ N ⑤

OF VICE NOT PRESCO

### PACKAGE DIMENSIONS

### PLCC-20 **FN SUFFIX**

PLASTIC PLCC PACKAGE CASE 775-02 ISSUE C



- OTES:

  1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOP OF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE.

  2. DIMENSION G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE.

  3. DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.010 (0.250) PER SIDE.

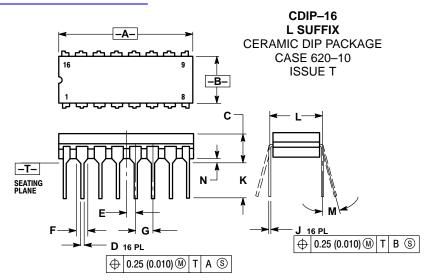
  4. DIMENSIONING AND TOLERANCING PER ANSI V14 5M 1982
- Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
- DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 (0.635).

	IN O		8411 1 184	ETERO
		HES		ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.385	0.395	9.78	10.03
В	0.385	0.395	9.78	10.03
С	0.165	0.180	4.20	4.57
Ε	0.090	0.110	2.29	2.79
F	0.013	0.019	0.33	0.48
G	0.050	BSC	1.27	BSC
Н	0.026	0.032	0.66	0.81
J	0.020		0.51	
K	0.025		0.64	
R	0.350	0.356	8.89	9.04
U	0.350	0.356	8.89	9.04
٧	0.042	0.048	1.07	1.21
W	0.042	0.048	1.07	1.21
Χ	0.042	0.056	1.07	1.42
Υ		0.020		0.50
Z	2°	10°	2 °	10 °
G1	0.310	0.330	7.88	8.38
K1	0.040		1.02	

### MC10135

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### PACKAGE DIMENSIONS



### NOTES:

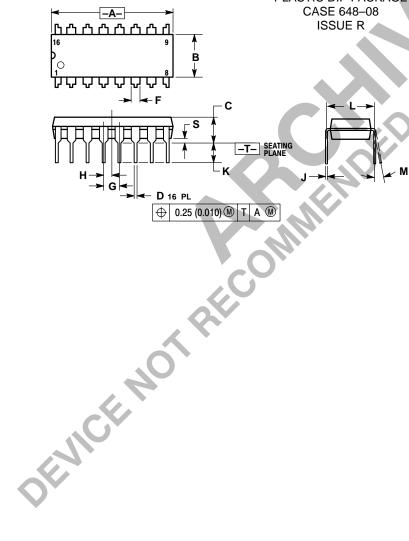
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
   CONTROLLING DIMENSION: INCH.
   DIMENSION LTO CENTER OF LEAD WHEN CONTROLLING DIMENSION LTO CENTER OF LEAD WHEN

- FORMED PARALLEL

  DIMENSION F MAY NARROW TO 0.76 (0.030)
  WHERE THE LEAD ENTERS THE CERAMIC
  BODY.

	INC	HES	MILLIN	IETERS	
DIM	MIN MAX		MIN	MAX	
Α	0.750	0.785	19.05	19.93	
В	0.240	0.295	6.10	7.49	
С		0.200		5.08	
D	0.015	0.020	0.39	0.50	
E	0.050	BSC	1.27 BSC		
F	0.055	0.065	1.40	1.65	
G	0.100	BSC	2.54 BSC		
Н	0.008	0.015	0.21	0.38	
K	0.125	0.170	3.18	4.31	
L	0.300 BSC		7.62	BSC	
M	0 °	15°	0° 15°		
N	0.020	0.040	0.51	1.01	

### PDIP-16 **P SUFFIX** PLASTIC DIP PACKAGE CASE 648-08 ISSUE R



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
  4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
  5. ROUNDED CORNERS OPTIONAL

	INC	HES	MILLIN	IETERS
DIM	M MIN MAX		MIN	MAX
Α	0.740	0.770	18.80	19.55
В	0.250	0.270	6.35	6.85
C	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.70	1.02	1.77
G	0.100	BSC	2.54	BSC
Н	0.050	BSC	1.27	BSC
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0°	10°	0°	10 °
S	0.020	0.040	0.51	1.01





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